

<b>Notice of References Cited</b>	Application/Control No. 10/700,215	Applicant(s)/Patent Under Reexamination SEVIER, RICHARD G.	
	Examiner William C. Storey	Art Unit 2609	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-4,839,740 A	06-1989	Yoshida, Eiichi	358/498
*	B	US-5,796,496 A	08-1998	Ono, Kenichi	358/498
*	C	US-2004/0145770 A1	07-2004	Nakano et al.	358/001.15
*	D	US-2005/0200903 A1	09-2005	Okubo, Nobuyuki	358/003.24
*	E	US-2003/0048470 A1	03-2003	Garcia, Elias S.	358/1.15
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	05-048835	02-1993	Japan	Furumura Masakazu	h04n 1/04
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

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